

# P-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
- 40	$0.0046$ at $V_{GS} = -10 \text{ V}$	- 90	105 nC			
- 40	$0.0065$ at $V_{GS} = -4.5 \text{ V}$	- 70	105110			

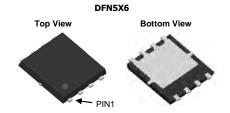
#### **FEATURES**

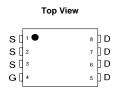
- **DT-Trench Power MOSFET**
- 100 % R<sub>g</sub> and UIS Tested

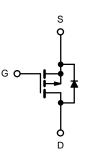


## **APPLICATIONS**

- Notebook
  - Load Switch







P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 40	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20			
	T <sub>C</sub> = 25 °C		- 90 <sup>a</sup>		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I-	- 70 <sup>a</sup>		
Continuous Drain Current (1 <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 25 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 13 <sup>b, c</sup>	A	
Pulsed Drain Current	I <sub>DM</sub>	- 360	7		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	l <sub>a</sub>	- 90 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>s</sub>	- 42 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 88		
Single Pulse Avalanche Energy	L = 0.111111	E <sub>AS</sub>	260	mJ	
	T <sub>C</sub> = 25 °C		138		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	83	$\Box$ w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	' D	7.15 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		4.3 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature	-	260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	20	35	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.9	1.2		

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.

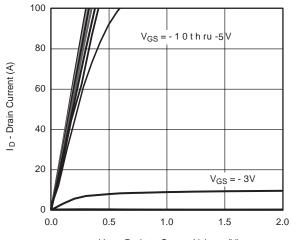


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	1				l .		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 40			V	
V <sub>DS</sub> Temperature Coefficient	AVps/Tu			- 31		~\\/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		6.5		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0		$V_{DS} = -32 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 32 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 10 V	- 90			Α	
	<u> </u>	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 20 A		0.0046 0.0059		-	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 15 A		0.0065	0.0088	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 20 A		17		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			5090			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -32 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		675		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			290			
Total Gate Charge	Qg	V <sub>DS</sub> = - 32 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 20 A		105	150	nC	
				78	130		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -32 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -15 \text{ A}$		19			
Gate-Drain Charge	$Q_{gd}$			27			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.9		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			35			
Rise Time	t <sub>r</sub>	$V_{DD} = -32 \text{ V}, R_{L} = 15 \Omega$		15			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 1.0 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		110		ns	
Fall Time	t <sub>f</sub>			60			
Turn-On Delay Time	t <sub>d(on)</sub>			45			
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 32 V, $R_L$ = 15 $\Omega$		19			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 1.0 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		190			
Fall Time	t <sub>f</sub>			70			
<b>Drain-Source Body Diode Characteristi</b>	cs				<u> </u>		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 90	۸	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 360	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 5 A		- 0.6	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			50	100	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 25 A dl/dt 400 A/ T 05 00		65	130	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 3.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		26		ns ns	
Reverse Recovery Rise Time	t <sub>b</sub>			24			

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$  b. Guaranteed by design, not subject to production testing.

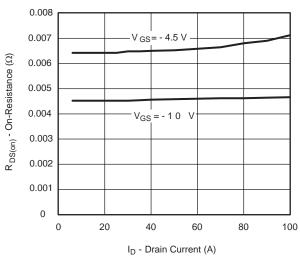
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



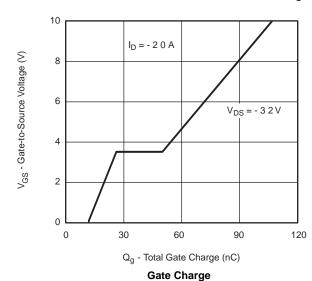


 $V_{\text{DS}}$  - Drain-to-Source Voltage (V)

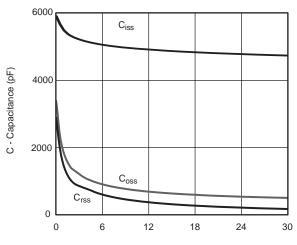
## **Output Characteristics**



#### On-Resistance vs. Drain Current and Gate Voltage

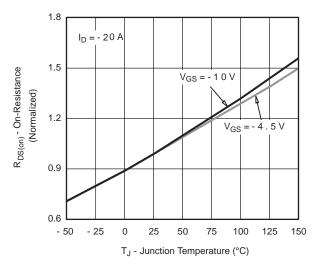


V<sub>DS</sub> - Drain-to-Source Voltage (V) **Transfer Characteristics** 



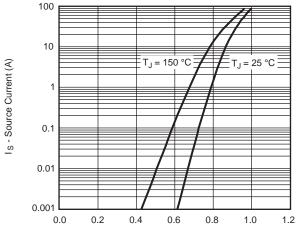
 $V_{\text{DS}}$  - Drain-to-Source Voltage (V)

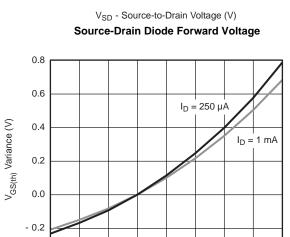
# Capacitance



On-Resistance vs. Junction Temperature







T<sub>J</sub> - Temperature (°C)

Threshold Voltage

50

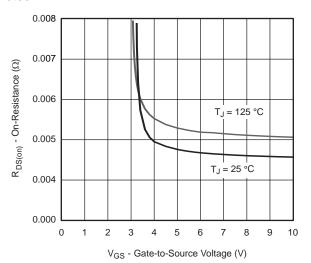
25

75

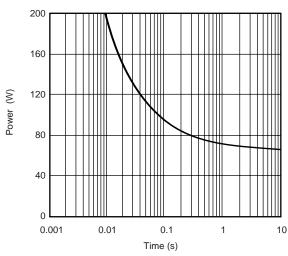
100

125

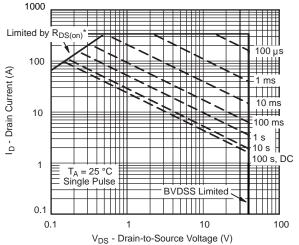
150



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

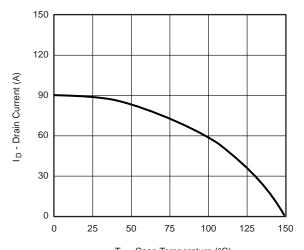
Safe Operating Area, Junction-to-Ambient

- 0.4

- 50

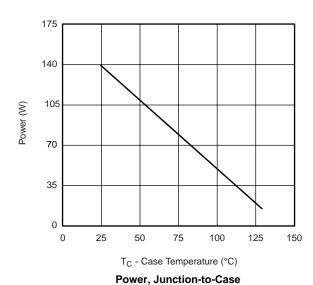
- 25

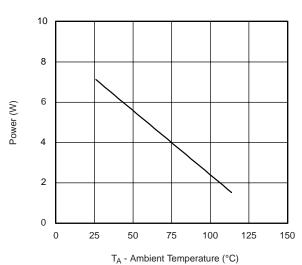




 $T_{\mbox{\scriptsize C}}$  - Case Temperature (°C)

### **Current Derating\***

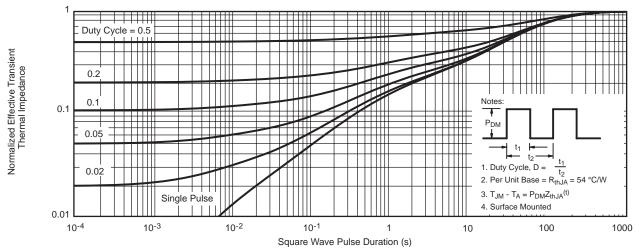




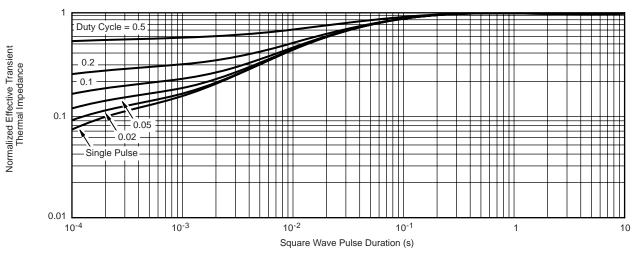
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





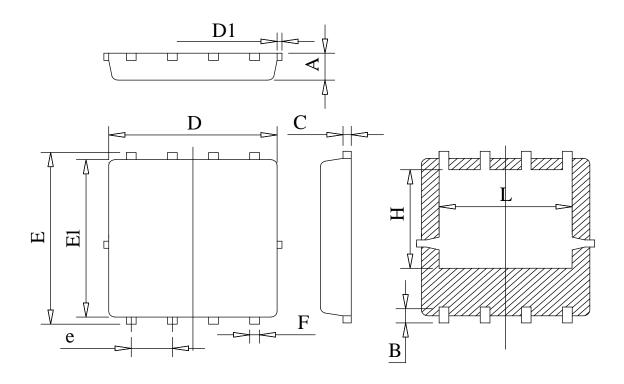
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



# **DFN5X6-8L PACKAGE OUTLINE**



# **COMMON DIMENSIONS** (UNITS OF MEASURE=MILLIMETER)

Unit: mm

Symbol	Min	Тур	Max
A	0.78	0.95	1.12
В	0.45	0.58	0.78
C	0.18	0.254	0.36
D	4.70	5.20	5.45
D1			0.18
Е	5.85	6.05	6.25
E1	5.38	5.55	5.98
e	1.15	1.27	1.40
F	0.18	0.30	0.52
Н	3.25	3.47	3.70
L	3.75	4.00	4.25





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